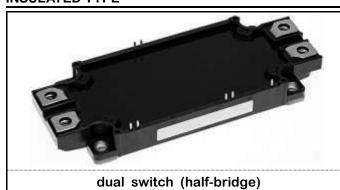


<IGBT Modules>

CM150DX-34SA

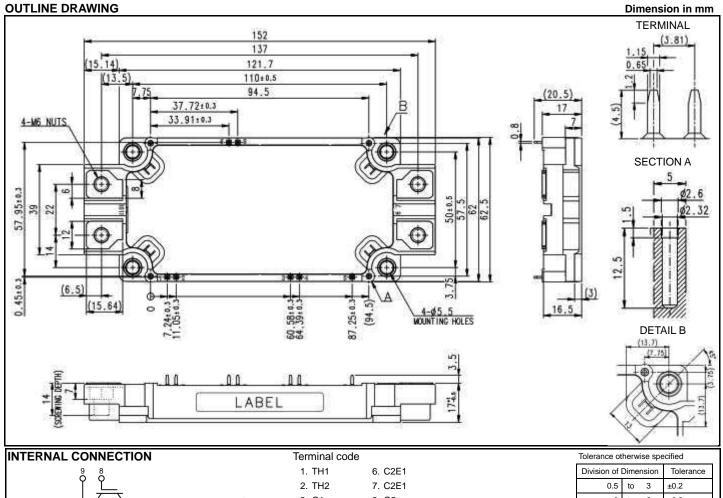
HIGH POWER SWITCHING USE INSULATED TYPE

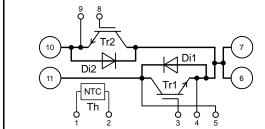


- Flat base type
- Copper base plate (Nickel-plating)
- •RoHS Directive compliant
- Tin-plating pin terminals
- •UL Recognized under UL1557, File No. E323585

APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.





Tomminal boat	
1. TH1	6. C2E1
2. TH2	7. C2E1
3. G1	8. G2
4. Es1	9. Es2
5. Cs1	10. E2
	11. C1

1

Tolerance otherwise specified						
Division of Dimension				Tolerance		
	0.5	to	3	±0.2		
over	3	to	6	±0.3		
over	6	to	30	±0.5		
over	30	to '	120	±0.8		
over	120	to 4	400	±1.2		

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HIGH POWER SWITCHING USE

INSULATED TYPE

MAXIMUM RATINGS (Tvj=25 °C, unless otherwise specified)

INVERTER PART IGBT/FWD

Symbol	Item	Conditions	Rating	Unit
V _{CES}	Collector-emitter voltage	G-E short-circuited	1700	V
V _{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
Ic	Collector current	DC, T _C =125 °C (Note2, 4)	150	Λ
I _{CRM}	Collector current	Pulse, Repetitive (Note3)	300	Α
P _{tot}	Total power dissipation	T _C =25 °C (Note2, 4)	1500	W
I _E (Note1)	Emitter current	DC (Note2)	150	^
I _{ERM} (Note1)	Emilier current	Pulse, Repetitive (Note3)	300	Α

MODULE

Symbol	Item	Conditions	Rating	Unit
V _{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload)	175	°C
T _{Cmax}	Maximum case temperature	(Note4)	125	
T _{vjop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ + 150	°C
T _{stq}	Storage temperature	-	-40 ~ +125	C

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified) **INVERTER PART IGBT/FWD**

Symbol	Item	Conditions			Limits		Unit
Syllibol	item	Conditions		Min.	Тур.	Max.	Offic
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1.0	mA
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited	V _{GE} =V _{GES} , C-E short-circuited			0.5	μΑ
$V_{GE(th)}$	Gate-emitter threshold voltage	I _C =15 mA, V _{CE} =10 V		5.4	6.0	6.6	V
		I _C =150 A, V _{GE} =15 V,	T _{vj} =25 °C	-	2.00	2.50	
V _{CEsat}		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.20	-	V
(Terminal)		(Note5)	T _{vj} =150 °C	-	2.25	-	
	Collector-emitter saturation voltage	Ic=150 A,	T _{vj} =25 °C	-	1.90	2.40	
V _{CEsat} (Chip)		V _{GE} =15 V,	T _{vi} =125 °C	-	2.10	-	V
		(Note5)	T _{vj} =150 °C	-	2.15	-	1
Cies	Input capacitance		•	-	-	40	
Coes	Output capacitance	V _{CE} =10 V, G-E short-circuited		-	-	3.3	nF
Cres	Reverse transfer capacitance			-	-	0.73	1
Q _G	Gate charge	V _{CC} =1000 V, I _C =150 A, V _{GE} =15 V		-	828	-	nC
t _{d(on)}	Turn-on delay time	V _{CC} =1000 V, I _C =150 A, V _{GE} =±15 V,		-	-	400	ns
tr	Rise time			-	-	100	
t _{d(off)}	Turn-off delay time			-	-	700	
tf	Fall time	R _G =0 Ω, Inductive load		-	-	600	1
(No. 1.4)		I _E =150 A, G-E short-circuited,	T _{vj} =25 °C	-	4.1	5.3	V
V _{EC} (Note1)		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.9	-	
(Terminal)	Facilities and land and the same	(Note5)	T _{vj} =150 °C	-	2.7	-	1
	Emitter-collector voltage	I _E =150 A,	T _{vj} =25 °C	-	4.0	5.2	
V _{EC} (Note1)		G-E short-circuited,	T _{vj} =125 °C	-	2.8	-	V
(Chip)		(Note5)	T _{vj} =150 °C	-	2.6	-	
t _{rr} (Note1)	Reverse recovery time	V _{CC} =1000 V, I _E =150 A, V _{GE} =±15 V,		-	-	300	ns
Q _{rr} (Note1)	Reverse recovery charge	R _G =0 Ω, Inductive load			5.0	-	μC
Eon	Turn-on switching energy per pulse	V _{CC} =1000 V, I _C =I _E =150 A,		-	26	-	1
E _{off}	Turn-off switching energy per pulse	$V_{GE}=\pm 15 \text{ V}, R_{G}=0 \Omega, T_{vj}=150 \text{ °C},$		-	46	-	mJ
211		Inductive load		_	32	_	mJ
E _{rr} (Note1)	Reverse recovery energy per pulse	inductive load	J	-	32		1110
	Reverse recovery energy per pulse Internal lead resistance	Main terminals-chip, per switch, T _c =25	5 °C (Note4)	-	-	1.4	mΩ

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HIGH POWER SWITCHING USE

INSULATED TYPE

ELECTRICAL CHARACTERISTICS (cont.; Tvj=25 °C, unless otherwise specified)

NTC THERMISTOR PART

Symbol	Itom	Conditions		Unit		
Symbol Item		Conditions	Min.	Тур.	Max.	Offile
R ₂₅	Zero-power resistance	T _C =25 °C (Note4)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R ₁₀₀ =493 Ω, T _C =100 °C (Note4)	-7.3	=	+7.8	%
B _(25/50)	B-constant	Approximate by equation (Note6)	=	3375	-	K
P ₂₅	Power dissipation	T _C =25 °C (Note4)	=	=	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Itom	Conditions		Unit		
Symbol Item		Conditions	Min.	Тур.	Max.	Offit
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per Inverter IGBT (Note4)	-	-	100	K/kW
$R_{th(j-c)D}$	Thermal resistance	Junction to case, per Inverter FWD (Note4)	-	-	160	N/KVV
D	Contact thermal resistance	Case to heat sink, Thermal grease applied (Note4, 7)	_	15	_	K/kW
$R_{th(c-s)}$	Contact theimal resistance	per 1 module,	-	13	-	IVINV

MECHANICAL CHARACTERISTICS

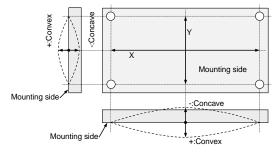
Cumbal	ltom	Conditions			Llait			
Symbol	Item	Conditions	Conditions		Тур.	Max.	Unit	
Mt	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N∙m	
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N∙m	
٨	Croonege distance	Terminal to terminal		17	-	-		
ds	Creepage distance	Terminal to base plate		18.5	=	-	mm	
٨	Clearance	Terminal to terminal		10	=	-		
da	Clearance	Terminal to base plate		16.3	=	-	mm	
ес	Flatness of base plate	On the centerline X, Y (Note8)		±0	=	+100	μm	
m	mass	-		-	350	-	g	

- *: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.
- Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).
 - 2. Junction temperature $(T_{\nu j})$ should not increase beyond $T_{\nu j\,m\,a\,x}$ rating.
 - 3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed $T_{vj\,m\,a\,x}$ rating.
 - 4. Case temperature (T_C) and heat sink temperature (T_S) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
 - 5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
 - 6. $B_{(25/50)} = ln(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} \frac{1}{T_{50}})$

 $R_{25}\!\!:$ resistance at absolute temperature $T_{25}\left[K\right];$ $T_{25}\!\!=\!\!25\left[^{\circ}C\right]\!\!+\!\!273.15\!\!=\!\!298.15\left[K\right]$

 $R_{50}\!:$ resistance at absolute temperature T_{50} [K]; $T_{50}\!=\!50$ [°C]+273.15=323.15 [K]

- 7. Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K)/D_(C-S)=50 μ m.
- 8. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



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HIGH POWER SWITCHING USE

INSULATED TYPE

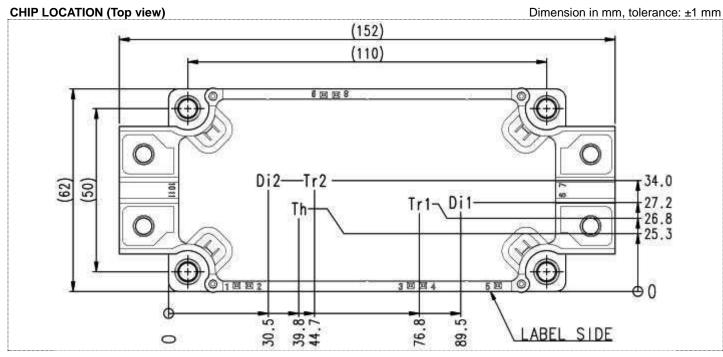
Note9. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

PCB thickness: t1.0~t1.6

	Туре	Manufacturer	Size	Tightening torque (N·m)	Recommended tightening method
(1)	PT®	EJOT	K25×8	0.55 ± 0.055	
(2)	PT®		K25×10	0.75 ± 0.075 N·m	by handwork (equivalent to 30 r/min
(3)	DELTA PT®		25×8	0.55 ± 0.055 N·m	by mechanical screw driver)
(4)	DELTA PT®		25×10	0.75 ± 0.075 N·m	~ 600 r/min (by mechanical screw driver)
(5)	B1	-	φ2.6×10	0.75 ± 0.075 N·m	
	tapping screw		φ2.6×12	0.75 ± 0.075 N-III	

RECOMMENDED OPERATING CONDITIONS

Cumbal	lto	Conditions		Unit		
Symbol Item		Conditions			Тур.	Max.
Vcc	(DC) Supply voltage	Applied across C1-E2 terminals	-	1000	1200	V
V _{GEon}	Gate (-emitter drive) voltage	Applied across G1-E1s/G2-E2s terminals	13.5	15.0	16.5	V
R _G	External gate resistance	Per switch	0	-	50	Ω



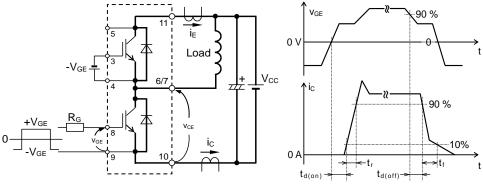
Tr1/Tr2: IGBT, Di1/Di2: FWD, Th: NTC thermistor

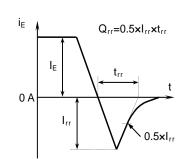
4

HIGH POWER SWITCHING USE

INSULATED TYPE

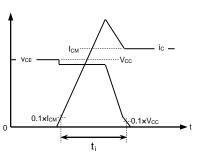
TEST CIRCUIT AND WAVEFORMS

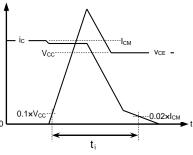


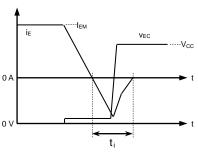


Switching characteristics test circuit and waveforms









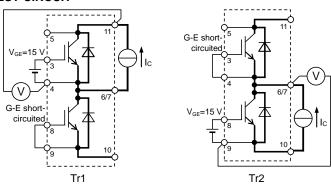
IGBT Turn-on switching energy

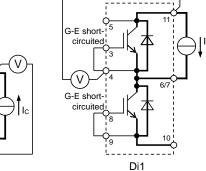
IGBT Turn-off switching energy

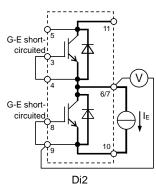
FWD Reverse recovery energy

Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

TEST CIRCUIT







V_{CEsat} characteristics test circuit

Ver.1.1

V_{EC} characteristics test circuit

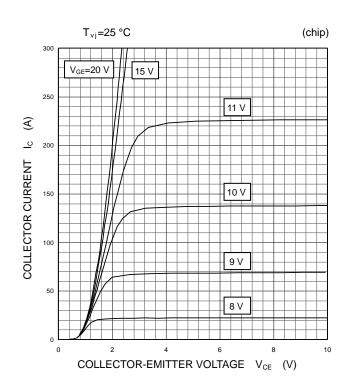
HIGH POWER SWITCHING USE

INSULATED TYPE

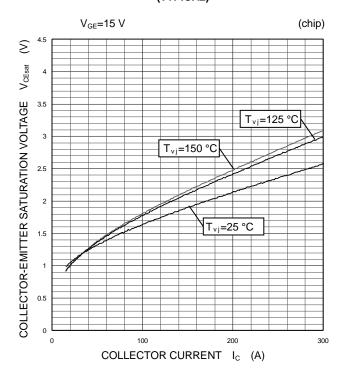
PERFORMANCE CURVES

INVERTER PART

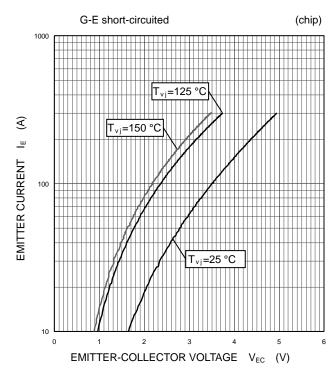
OUTPUT CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



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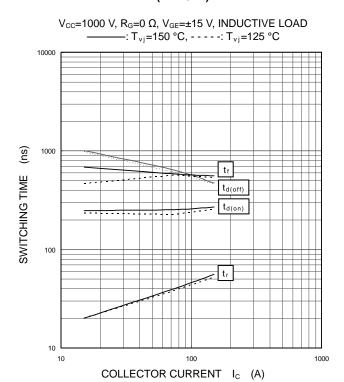
HIGH POWER SWITCHING USE

INSULATED TYPE

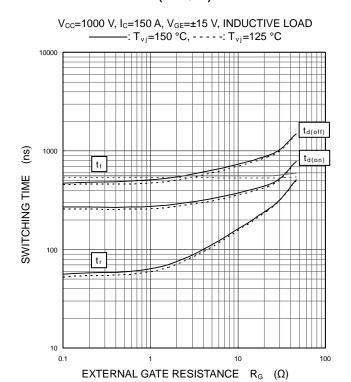
PERFORMANCE CURVES

INVERTER PART

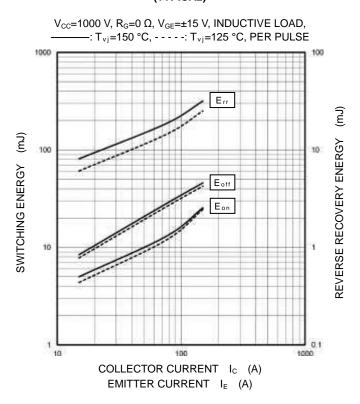
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

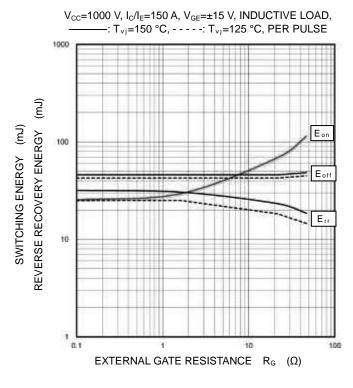


HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



Ver.1.1

HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



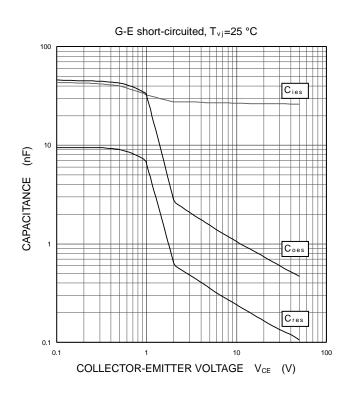
HIGH POWER SWITCHING USE

INSULATED TYPE

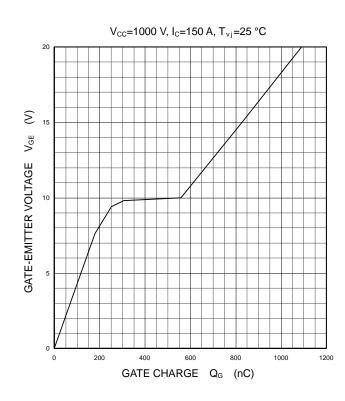
PERFORMANCE CURVES

INVERTER PART

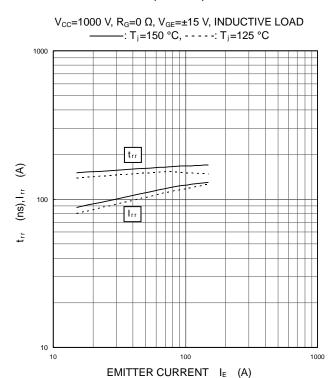
CAPACITANCE CHARACTERISTICS (TYPICAL)



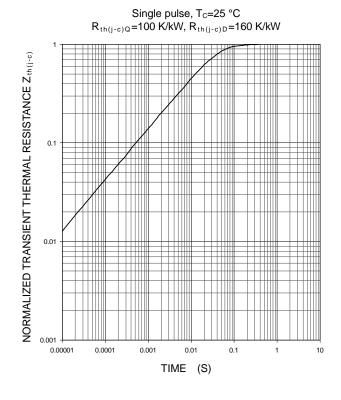
GATE CHARGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

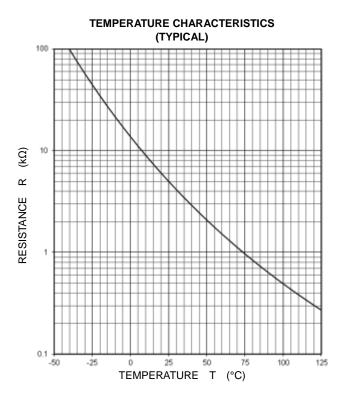


HIGH POWER SWITCHING USE

INSULATED TYPE

PERFORMANCE CURVES

NTC thermistor part



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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